

<b>Notice of References Cited</b>	Application/Control No. 10/676,449	Applicant(s)/Patent Under Reexamination KRIVOKAPIC, IVAN	
	Examiner Jia W. Lu	Art Unit 2634	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,822,508	11-2004	Yoon et al.	329/319
	B	US-6,529,568	03-2003	Richards et al.	375/346
	C	US-4,270,209	05-1981	Albanese, Damian F.	375/343
	D	US-4,846,920	07-1989	Keller et al.	156/345.25
	E	US-2003/0093447	05-2003	Hwang, Sung-hyun	708/312
	F	US-2004/0121728	06-2004	Gibson et al.	455/012.1
	G	US-6,378,080	04-2002	Anjo et al.	713/500
	H	US-3,906,453	09-1975	Mattedi et al.	711/107
	I	US-6,850,733	02-2005	McCorkle et al.	455/41.2
	J	US-6,505,032	01-2003	McCorkle et al.	455/41.2
	K	US-6,160,259	12-2000	Petrillo et al.	250/363.07
	L	US-5,920,278	07-1999	Tyler et al.	342/33
	M	US-5,291,202	03-1994	McClintock, William J.	342/16

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.